

## AUIRFR5305 AUIRFU5305

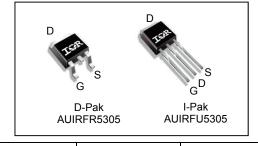
#### Features

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

#### Description

Specifically designed for Automotive applications, this Cellular Planar design of HEXFET<sup>®</sup> Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

	V <sub>DSS</sub>		-55V
)	R <sub>DS(on)</sub>	max.	0.065Ω
	I <sub>D</sub>		-31A



G	D	S
Gate	Drain	Source

Bees nort number	Dookogo Turoo	Standard Pack		Ordershie Port Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFU5305	I-Pak	Tube	75	AUIRFU5305
AUIRFR5305	D Dek	Tube	75	AUIRFR5305
AUIRER3305	D-Pak	Tape and Reel Left	3000	AUIRFR5305TRL

#### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-31	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-22	А
I <sub>DM</sub>	Pulsed Drain Current ① 6	-110	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 26	280	mJ
I <sub>AR</sub>	Avalanche Current 0 6	-16	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	11	mJ
dv/dt	Peak Diode Recovery dv/dt36	-5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

#### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case		1.4	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient ®		110	

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\*Qualification standards can be found at www.infineon.com



#### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.034		V/°C	Reference to 25°C, $I_D = -1mA$
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.065	Ω	V <sub>GS</sub> = -10V, I <sub>D</sub> = -16A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	-2.0		-4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250µA
gfs	Forward Trans conductance	8.0			S	V <sub>DS</sub> = -25V, I <sub>D</sub> = -16A ⑥
1	Drain-to-Source Leakage Current			-25	μA	V <sub>DS</sub> = -55 V, V <sub>GS</sub> = 0V
IDSS	Drain-to-Source Leakage Current			-250	μΑ	V <sub>DS</sub> = -44V,V <sub>GS</sub> = 0V,T <sub>J</sub> =150°C
1	Gate-to-Source Forward Leakage			-100	5	V <sub>GS</sub> = -20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			100	nA	V <sub>GS</sub> = 20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

-	<b>–</b> •		-			
Q <sub>g</sub>	Total Gate Charge			63		I <sub>D</sub> = -16A
$Q_{gs}$	Gate-to-Source Charge			13	nC	$V_{DS} = -44V$
$Q_{gd}$	Gate-to-Drain Charge			29		$V_{GS}$ = -10V, See Fig 6 and 13 $\oplus$ (6)
t <sub>d(on)</sub>	Turn-On Delay Time		14			$V_{DD} = -28V$
t <sub>r</sub>	Rise Time		66		ne	I <sub>D</sub> = -16A
t <sub>d(off)</sub>	Turn-Off Delay Time		39		ns	$R_G = 6.8\Omega$
t <sub>f</sub>	Fall Time		63			R <sub>D</sub> = 1.6Ω, See Fig 10 ④⑥
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
C <sub>iss</sub>	Input Capacitance		1200			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		520		pF	V <sub>DS</sub> = -25V
C <sub>rss</sub>	Reverse Transfer Capacitance		250			f = 1.0MHz, See Fig. 5⑥
Diode Cha	racteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			-31		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			-110	A	integral reverse
V <sub>SD</sub>	Diode Forward Voltage			-1.3	V	T <sub>J</sub> = 25°C,I <sub>S</sub> = -16A,V <sub>GS</sub> = 0V ④

110

250

71

170

ns

nC

T」= 25°C,I<sub>F</sub> = -16A

di/dt = 100A/µs @6

#### Notes:

Qn

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

②  $V_{DD}$  = -25V, starting T<sub>J</sub> = 25°C, L = 2.1mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = -16A. (See Fig.12)

 $\label{eq:ISD} \textcircled{3} \quad I_{SD} \leq \textbf{-16A}, \, di/dt \leq \textbf{-280A}/\mu s, \, V_{DD} \leq V_{(BR)DSS}, \, T_J \leq 175^\circ C.$ 

Reverse Recovery Time

Reverse Recovery Charge

④ Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%.

⑤ This is applied for I-PAK, L<sub>S</sub> of D-PAK is measured between lead and center of die contact .

Uses IRF5305 data and test conditions. 6

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to Ø application note #AN-994

8 Uses typical socket mount.



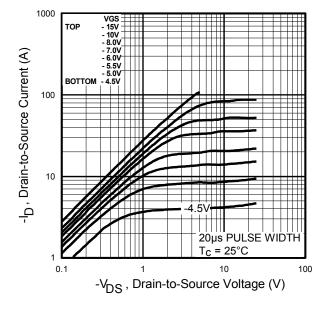


Fig. 1 Typical Output Characteristics

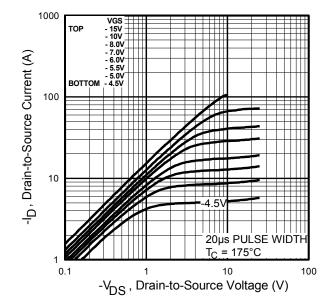


Fig. 2 Typical Output Characteristics

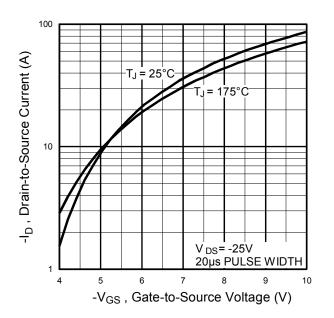


Fig. 3 Typical Transfer Characteristics

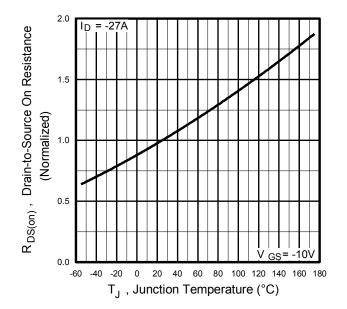
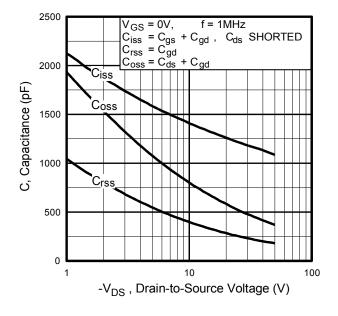
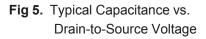
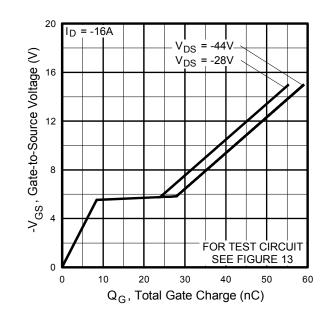


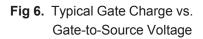
Fig. 4 Normalized On-Resistance vs. Temperature

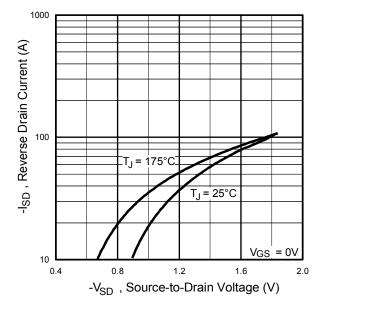


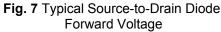












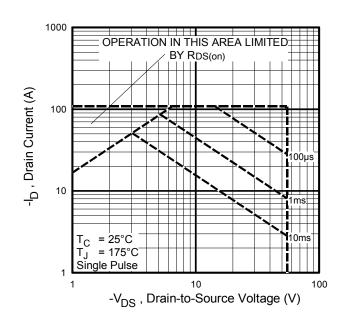


Fig 8. Maximum Safe Operating Area



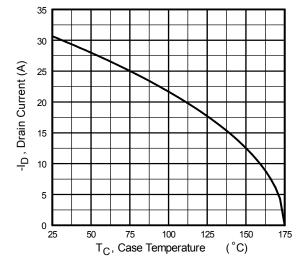
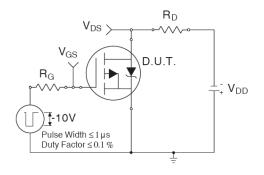


Fig 9. Maximum Drain Current vs. Case Temperature



### Fig 10a. Switching Time Test Circuit

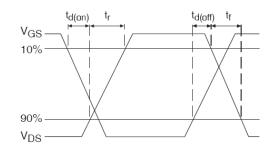


Fig 10b. Switching Time Waveforms

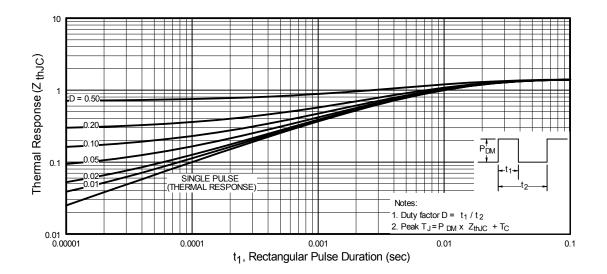


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

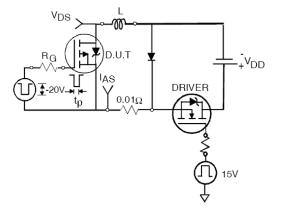


Fig 12a. Unclamped Inductive Test Circuit

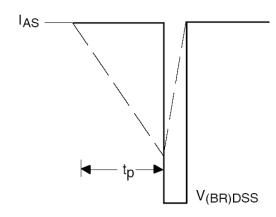


Fig 12b. Unclamped Inductive Waveforms

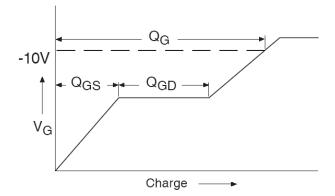


Fig 13a. Gate Charge Waveform

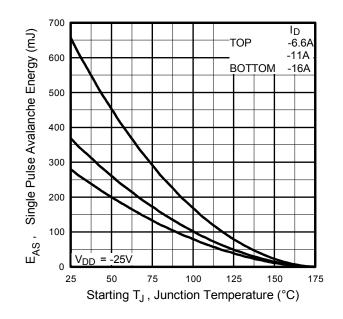


Fig 12c. Maximum Avalanche Energy vs. Drain Current

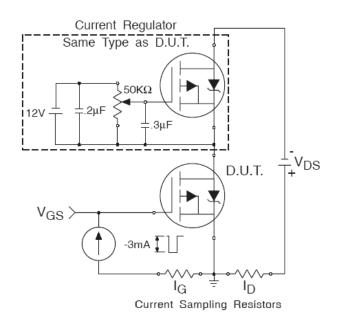


Fig 13b. Gate Charge Test Circuit



## Peak Diode Recovery dv/dt Test Circuit

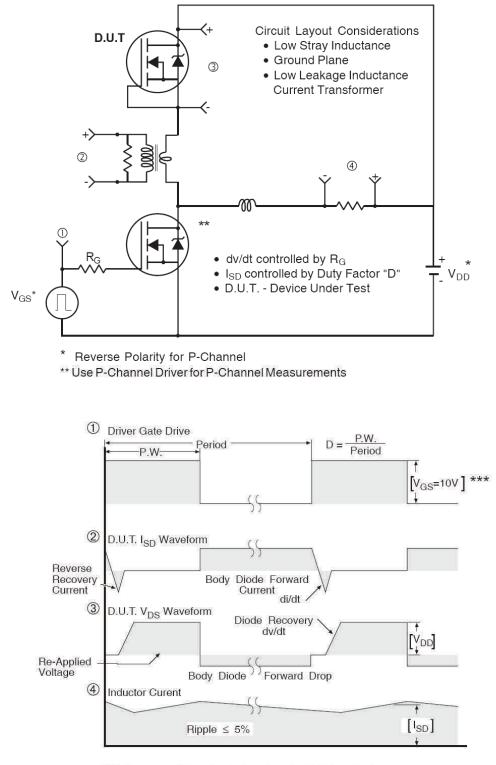
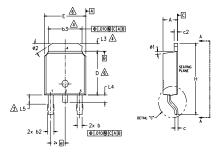




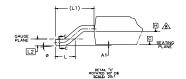
Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

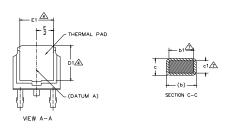


### D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- A- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- NLY.
- LANE H. AA.

<u>A-</u>	DIMENSION 61 & c1 APPLIED TO BASE METAL ON						
_	DATUM A & B TO BE DETERMINED AT DATUM PL						
_			S TO JEDE				
J.			5 10 000			2524	
S Y			CIONIC				
M			ISIONS		N O		
B O	MILLIM	ETERS	INC	HES			
L	MIN.	MAX.	MIN.	MAX.	E S		
Α	2.18	2.39	.086	.094			
A1	-	0.13	-	.005			
b	0.64	0.89	.025	.035			
ь1	0.65	0.79	.025	.031	7		
b2	0.76	1.14	.030	.045			
b3	4.95	5.46	.195	.215	4		
с	0.46	0.61	.018	.024			
c1	0.41	0.56	.016	.022	7		
c2	0.46	0.89	.018	.035			
D	5.97	6.22	.235	.245	6		
D1	5.21	-	.205	-	4		
E	6.35	6.73	.250	.265	6		
E1	4.32	-	.170	-	4		
е	2.29	BSC	.090	BSC			
н	9.40	10.41	.370	.410			
L	1.40	1.78	.055	.070			
L1	2.74 BSC		.108	REF.			
L2	0.51	BSC	.020	BSC			
L3	0.89	1.27	.035	.050	4		
L4	-	1.02	-	.040			
L5	1.14	1.52	.045	.060	3		
ø	0.	10°	0.	10*			

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

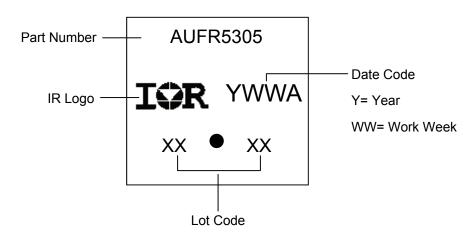
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

## D-Pak (TO-252AA) Part Marking Information



ø1 0°

ø2 25' 15°

35'

0'

25'

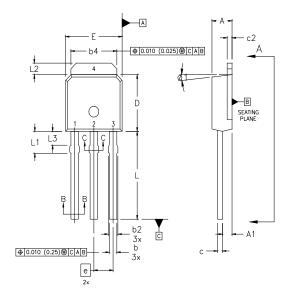
15°

35'

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



## I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994. 1
- 2
- DIMENSION ARE SHOWN IN MILLIMETERS [INCHES]. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 3
- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1. 4 LEAD DIMENSION UNCONTROLLED IN L3. 5
- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA. 8
- CONTROLLING DIMENSION : INCHES.

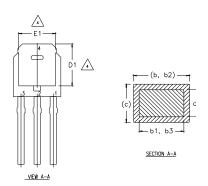
LEAD ASSIGNMENTS

```
HEXFET
```

1.- GATE

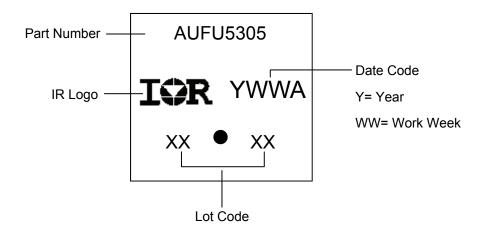
2.- DRAIN 3.- SOURCE

4.- DRAIN



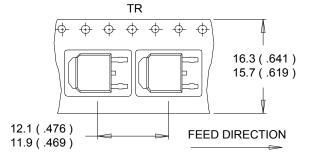
SYMBOL	MILLIMETERS		MILLIMETERS INCHES		
	Min.	MAX.	MIN.	MAX.	NOTES
A	2.18	2.39	0.086	.094	
A1	0.89	1.14	0.035	0.045	
b	0.64	0.89	0.025	0.035	
ь1	0.64	0.79	0.025	0.031	4
b2	0.76	1.14	0.030	0.045	
b3	0.76	1.04	0.030	0.041	
b4	5.00	5.46	0.195	0.215	4
с	0.46	0.61	0.018	0.024	
c1	0.41	0.56	0.016	0.022	
c2	.046	0.86	0.018	0.035	
D	5.97	6.22	0.235	0.245	3, 4
D1	5.21	-	0.205	-	4
E	6.35	6.73	0.250	0.265	3, 4
E1	4.32	-	0.170	-	4
е	2.	29	0.090	BSC	
L	8.89	9.60	0.350	0.380	
L1	1.91	2.29	0.075	0.090	
L2	0.89	1.27	0.035	0.050	4
L3	1.14	1.52	0.045	0.060	5
ø1	0.	15*	0.	15*	

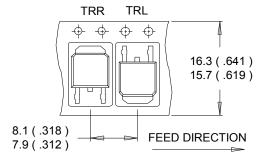
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

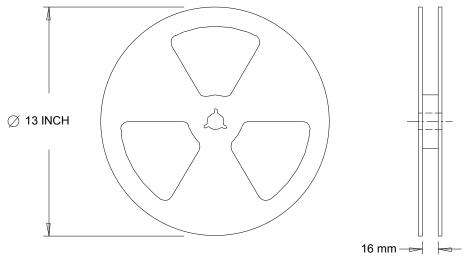
### D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





#### NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



#### NOTES : 1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



### **Qualification Information**

		Automotive (per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Majatura Sanaitivity Laval		D-Pak	MSL1		
woisture	Moisture Sensitivity Level		WISE I		
			Class M2 (+/- 200V) <sup>†</sup>		
	Machine Model	AEC-Q101-002			
500		Class H1B (+/- 1000V) <sup>†</sup>			
ESD	Human Body Model	AEC-Q101-001			
			Class C5 (+/- 1125V) <sup>†</sup>		
	Charged Device Model	AEC-Q101-005			
RoHS Compliant		Yes			

† Highest passing voltage.

#### **Revision History**

Date	Comments		
10/12/2015	Updated datasheet with corporate template		
10/12/2013	Corrected ordering table on page 1.		

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